





West et al.

Docket No.: TI-36238

Serial No.:

10/697,137

Examiner:

Guerrero, M.

Filing Date:

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Art Unit:

2822

Customer No.:

23494

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9756

Title: METHOD FOR IMPROVING RELIABILITY OF COPPER INTERCONNECTS

TRANSMITTAL OF FORMAL DRAWINGS

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Attn: Official Draftsperson

Dear Sir:

MAILING CERTIFICATE UNDER 37 C.F.R. §1.8(A)

I hereby certify that the above correspondence is being deposited with the U.S. Postal Service as First Class Mail in an envelope addressed to: Commissioner of Patents, P. O. Box 1450, Alexandria, VA 22313-1450.

Marianna Smith

Date:

Submitted herewith are three (3) sheets of formal drawings.

Charge any necessary fee to Deposit Account No. 20-0668. The original and a copy of this authorization are enclosed.

Respectfully submitted,

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